AD580* Product Page Quick Links

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Application Notes

• AN-713: The Effect of Long-Term Drift on Voltage References

Data Sheet

- AD580: High Precision 2.5 V IC Reference Data Sheet
- AD580: Military Data Sheet

Design Resources <a>□

- · AD580 Material Declaration
- PCN-PDN Information
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- · Symbols and Footprints

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AD580

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REVISION HISTORY

8/04—Changed from Rev. A to Rev. B

SPECIFICATIONS

Table 1. $V_{IN} = 15 \text{ V}$ and 25°C

	AD580J		AD580K			AD580L			AD580M				
Model	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Units
OUTPUT VOLTAGE TOLERANCE													
Error from Nominal 2.500 V Output			±75			±25			±10			±10	mV
OUTPUT VOLTAGE CHANGE													
T _{MIN} to T _{MAX}			15			7			4.3			1.75	mV
			85			40			25			10	ppm/°C
LINE REGULATION													
$7~V \leq V_{IN} \leq 30~V$		1.5	6 ¹		1.5	4			2			2	mV
$4.5~V \leq V_{IN} \leq 7~V$		0.3	3		0.3	2			1			1	mV
LOAD REGULATION													
$\Delta I = 10 \text{ mA}$			10			10			10			10	mV
QUIESCENT CURRENT		1.0	1.5		1.0	1.5		1.0	1.5		1.0	1.5	mA
NOISE (0.1 Hz to 10 Hz)		8			8			8			8		μV p-p
STABILITY													
Long Term		250			250			250			250		μV
Per Month		25			25			25			25		μV
TEMPERATURE PERFORMANCE													
Specified	0		+70	0		+70	0		+70	0		+70	°C
Operating	-55		+125	-55		+125	-55		+125	-55		+125	°C
Storage	-65		+175	-65		+175	-65		+175	-65		+175	°C
PACKAGE OPTION ² TO-52 (H-03A)		AD580.	JH	,	4D580k	(H		AD580L	.H	A	D580N	ΛΗ	

Table 2.

		AD580	S	AD580T		AD580U				
Model	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Units
OUTPUT VOLTAGE TOLERANCE										
Error from Nominal 2.500 V Output			±25 ¹			±10			±10	mV
OUTPUT VOLTAGE CHANGE										
T _{MIN} to T _{MAX}			25			11			4.5	mV
			55			25			10	ppm/°C
LINE REGULATION										
$7~V \leq V_{IN} \leq 30~V$		1.5	6			2			2	mV
$4.5~V \leq V_{IN} \leq 7~V$		0.3	3			1			1	mV
LOAD REGULATION										
$\Delta I = 10 \text{ mA}$			10			10			10	mV
QUIESCENT CURRENT		1.0	1.5		1.0	1.5		1.0	1.5	mA
NOISE (0.1 Hz to 10 Hz)		8			8			8		μV p-p
STABILITY										
Long Term		250			250			250		μV
Per Month		25			25			25		μV
TEMPERATURE PERFORMANCE										
Specified	-55		+125	-55		+125	-55		+125	°C
Operating	-55		+150	-55		+150	-55		+150	°C
Storage	-65		+175	-65		+175	-65		+175	°C
PACKAGE OPTION ² TO-52 (H-03A)		AD5809	SH		AD580	ГН		AD580l	JH	

¹ Specifications shown in **boldface** are tested on all production units at final electrical test. Results from those tests are used to calculate outgoing quality levels. All min and max specifications are guaranteed, although only those shown in **boldface** are tested on all production units.

² H = Metal Can.

AD580

ABSOLUTE MAXIMUM RATINGS

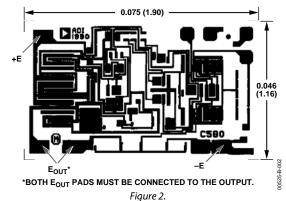
Table 3.

Parameter	Rating
Input Voltage	40 V
Power Dissipation @ 25°C	
Ambient Temperature	350 mW
Derate above 25°C	2.8 mW/°C
Lead Temperature (Soldering 10 sec)	300°C
Thermal Resistance	
Junction-to-Case	100°C
Junction-to-Ambient	360°C/W

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

AD580 CHIP DIMENSIONS AND PAD LAYOUT

Dimensions shown in inches and (millimeters).



The AD580 is also available in chip form. Consult the factory for specifications and applications information.

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



THEORY OF OPERATION

The AD580 family (AD580, AD581, AD584, AD589) uses the bandgap concept to produce a stable, low temperature coefficient voltage reference suitable for high accuracy data acquisition components and systems. The device makes use of the underlying physical nature of a silicon transistor base-emitter voltage in the forward-biased operating region. All such transistors have approximately a -2 mV/°C temperature coefficient, unsuitable for use directly as a low TC reference. Extrapolation of the temperature characteristic of any one of these devices to absolute zero (with an emitter current propor-tional to the absolute temperature), however, reveals that it will go to a V_{BE} of 1.205 V at 0 K, as shown in Figure 3. Thus, if a voltage could be developed with an opposing temperature coefficient to sum with VBE to total 1.205 V, a 0 TC reference would result and operation from a single, low voltage supply would be possible. The AD580 circuit provides such a compensating voltage, V1 in Figure 4, by driving two transistors at different current densities and amplifying the resulting V_{BE} difference (ΔV_{BE} —which now has a positive TC). The sum, Vz, is then buffered and amplified up to 2.5 V to provide a usable reference-voltage output. Figure 5 shows the schematic diagram of the AD580.

The AD580 operates as a 3-terminal reference, meaning that no additional components are required for biasing or current setting. The connection diagram, Figure 6, is quite simple.

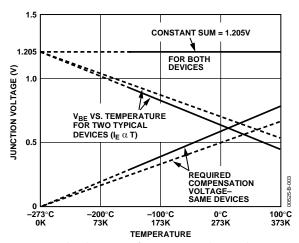


Figure 3. Extrapolated Variation of Base-Emitter Voltage with Temperature (IEaT), and Required Compensation, Shown for Two Different Devices

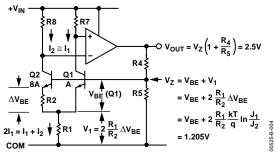
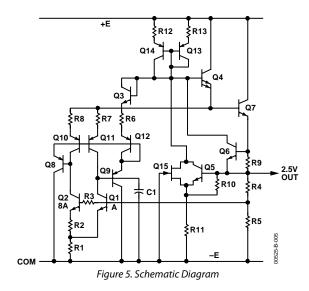


Figure 4. Basic Bandgap-Reference Regulator Circuit



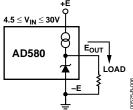


Figure 6. Connection Diagram

VOLTAGE VARIATION VERSUS TEMPERATURE

Some confusion exists in the area of defining and specifying reference voltage error over temperature. Historically, references are characterized using a maximum deviation per degree Centigrade; i.e., 10 ppm/°C. However, because of the inconsistent nonlinearities in Zener references (butterfly or S type characteristics), most manufacturers use a maximum limit error band approach to characterize their references. This technique measures the output voltage at 3 to 5 different temperatures and guarantees that the output voltage deviation will fall within the guaranteed error band at these discrete temperatures. This approach, of course, makes no mention or guarantee of performance at any other temperature within the operating temperature range of the device.

AD580

The consistent voltage versus temperature performance of a typical AD580 is shown in Figure 7. Note that the characteristic is quasi-parabolic, not the possible S type characteristics of classical Zener references. This parabolic characteristic permits a maximum output deviation specification over the device's full operating temperature range, rather than just at 3 to 5 discrete temperatures.

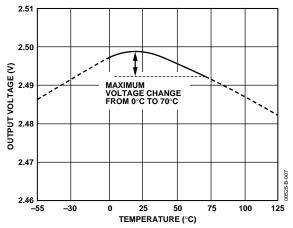


Figure 7. Typical AD580K Output Voltage vs. Temperature

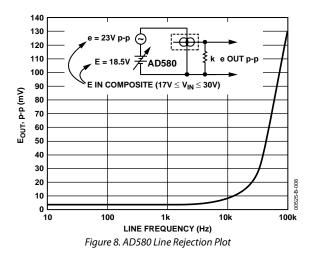
The AD580M guarantees a maximum deviation of 1.75 mV over the 0°C to 70°C temperature range. This can be shown to be equivalent to 10 ppm/°C average maximum; i.e.,

$$\frac{1.75 \, mV \, \text{max}}{70^{\circ} C} \times \frac{1}{2.5V} = 10 \, ppm/^{\circ} C \, \text{max average}$$

The AD580 typically exhibits a variation of 1.5 mV over the power supply range of 7 V to 30 V. Figure 8 is a plot of AD580 line rejection versus frequency.

NOISE PERFORMANCE

Figure 9 represents the peak-to-peak noise of the AD580 from 1 Hz (3 dB point) to a 3 dB high end shown on the horizontal axis. Peak-to-peak noise from 1 Hz to 1 MHz is approximately $600~\mu V$.



100µV

100µV

10µV

10µV

FREQUENCY (Hz)

Figure 9. Peak-to-Peak Output Noise vs. Frequency

1mV

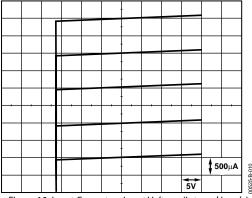


Figure 10. Input Current vs. Input Voltage (Integral Loads)

THE AD580 AS A CURRENT LIMITER

The AD580 represents an excellent alternative to current limiter diodes that require factory selection to achieve a desired current. This approach often results in temperature coefficients of 1%/C. The AD580 approach is not limited to a specially selected factory set current limit; it can be programmed from 1 mA to 10 mA with the insertion of a single external resistor. The approximate temperature coefficient of current limit for the AD580 used in this mode is $0.13\%/^{\circ}C$ for $I_{LIM}=1$ mA and $0.01\%/^{\circ}C$ for $I_{LIM}=13$ mA (see Figure 11). Figure 10 displays the high output impedance of the AD580 used as a current limiter for $I_{LIM}=1,2,3,4$, and 5 mA.

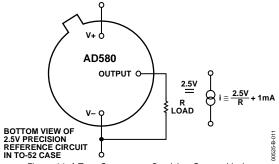


Figure 11. A Two-Component Precision Current Limiter

THE AD580 AS A LOW POWER, LOW VOLTAGE, PRECISION REFERENCE FOR DATA CONVERTERS

The AD580 has a number of features that make it ideally suited for use with A/D and D/A data converters used in complex microprocessor-based systems. The calibrated 2.500 V output minimizes user trim requirements and allows operation from a single, low voltage supply. Low power consumption (1 mA quiescent current) is commensurate with that of CMOS-type devices, while the low cost and small package complements the decreasing cost and size of the latest converters.

Figure 12 shows the AD580 used as a reference for the AD7542 12-bit CMOS DAC with complete microprocessor interface. The AD580 and the AD7542 are specified to operate from a single 5 V supply, thus eliminating the need to provide a 15 V power supply for the sole purpose of operating a reference. The AD7542 includes three 4-bit data registers, a 12-bit DAC register, and address decoding logic. It may thus be interfaced directly to a 4-, 8- or 16-bit data bus. Only 8 mA of quiescent current from the single 5 volt supply is required to operate the AD7542 which is packaged in a small, 16-pin DIP. The AD544

output amplifier is also low power, requiring only 2.5 mA quiescent current. Its laser-trimmed offset voltage preserves the $\pm 1/2$ LSB linearity of the AD7542KN without user trims, and it typically settles to $\pm 1/2$ LSB in less than 3 μ s. It will provide the 0 V to -2.5 V output swing from ± 5 V supplies.

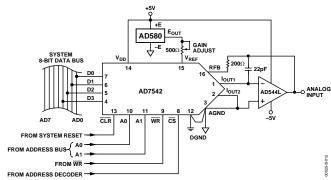
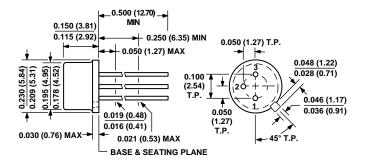


Figure 12. Low Power, Low Voltage Reference for the AD7542 Microprocessor-Compatible, 12-Bit DAC

OUTLINE DIMENSIONS



CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETERS DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN

Figure 13. TO–52 Package Dimensions shown in inches and (millimeters)

ORDERING GUIDE

Model	Output Voltage Tolerance	Temperature Coefficient	Operating Temperature Range	Package Option	Package Description
AD580JH	±75 mV	85 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580KH	±25 mV	40 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580LH	±10 mV	25 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580LMH	±10 mV	10 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580SH	±25 mV	55 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580SH/883B	±25 mV	55 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580TH	±10 mV	25 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580UH	±10 mV	10 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580UH/883B	±10 mV	10 ppm/°C	−55°C to +125°C	TO-52	H (Metal Can)
AD580TCHIPS	±10 mV			DIE	